

# SIGC158T120R3

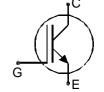
# IGBT<sup>3</sup> Chip

#### **FEATURES:**

- 1200V Trench + Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

## This chip is used for:

power module



## Applications:

drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code
SIGC158T120R3	1200V	150A	12.56 x 12.56 mm <sup>2</sup>	sawn on foil	Q67050- A4109-A001

## **MECHANICAL PARAMETER:**

Raster size	12.56 x 12.56				
Emitter pad size	8x(2.646 x 5.454)				
Gate pad size	1.139 x 1.139				
Area total / active	157.8 / 128.1				
Thickness	140				
Wafer size	150				
Flat position	90				
Max.possible chips per wafer	86 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm AlSiCu				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	Al, <500μm				
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



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#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	1200	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	450	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

# STATIC CHARACTERISTICS (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol Conditions	Value			Unit	
1 drameter		Containone	min.	typ.	max.	
Collector-emitter breakdown voltage	V <sub>(BR)CES</sub>	$V_{GE}$ =0 $V$ , $I_{C}$ = 6 mA	1200			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =150A	1.4	1.7	2.1	V
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	I <sub>C</sub> =6mA , V <sub>GE</sub> =V <sub>CE</sub>	5.0	5.8	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V , V <sub>GE</sub> =0V			20	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V , V <sub>GE</sub> =20V			600	nA
Integrated gate resistor	R <sub>Gint</sub>			5		Ω

## **ELECTRICAL CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailietei	Symbol	Conditions	min.	typ.	max.	Onne
Input capacitance	Ciss	V <sub>CE</sub> =25V,		10766		pF
Output capacitance	Coss	$V_{GE}=0V$ ,		563		
Reverse transfer capacitance	C <sub>rss</sub>	f=1MHz		488		

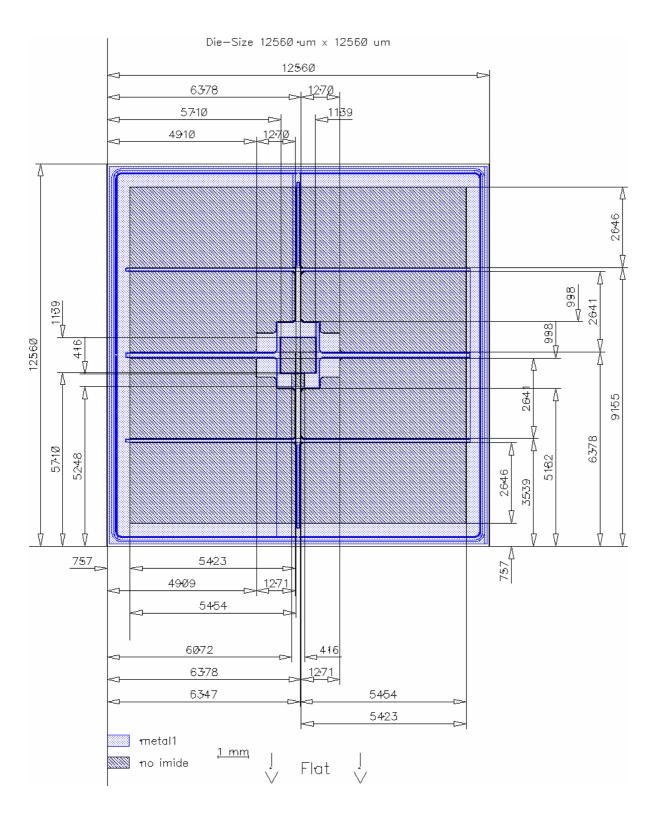
#### SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
			min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C		300		ns
Rise time	t <sub>r</sub>	V <sub>CC</sub> =600V, I <sub>C</sub> =150A, V <sub>GE</sub> =-15/15V,		95		
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = -15/15 \text{V},$		650		
Fall time	$t_{f}$	$R_{\rm G}$ = 8.2 $\Omega$		180		

<sup>&</sup>lt;sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



## **CHIP DRAWING:**





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#### **FURTHER ELECTRICAL CHARACTERISTICS:**

This chip data sheet refers to the device data sheet	tbd	
AQL 0,65 for visual inspection according to fail	ure catalog	
	ding to MIL-STD 883	

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